

QUALITY & RELIABILITY ENGINEERING FIT and MTTF Calculation Report

PN Family Series PUAD	8B – PUAD8D	
Part Description 8A, 10	0V - 200V Ultra Fast Surface Mount Rectifier	
Package Type Thin [PAK	
Test Variables:		
Stress Test	= HTRB	
No. of failures	= 0 units	
Sample Size	= 308 units	
Test Duration	= 1000 hours	
Total device hours	= 308000 hours	
Accelerated Temp (Ta)	= 175 ° C	
Operating Temp (Tu)	= 50 ° C	
Activation Energy (Ea)	= 1.0 eV	
Confidence Level	= 90 %	
Boltzman's Constant (k)	= 8.617E-05 eV / °K	
Calculations:		
Chi squared value	= 4.6051702 @ 90% Confidence Level	
Failure Rate (@accelerated condition)	= (Chi squared value) 2*(Sample Size)*(Test Duration)	
	= 7475.93 FIT	
Assolution Faster AF	$= e^{(Ea/k)(1/Tu - 1/Ta)}$	
Acceleration Factor, AF	= e = 22578.33597	
	= 22576.55597	
Results:		
Failure Rate (@operating condition)	= (Failure Rate @accelerated condition) / (AF)	\neg
	= 0.33 FIT	
Mean Time to Failure (MT	F) = 3.02E+09 hours	
	= 344765 years	
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